

HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

IDT7024S/L

T-46-23-12

FEATURES:

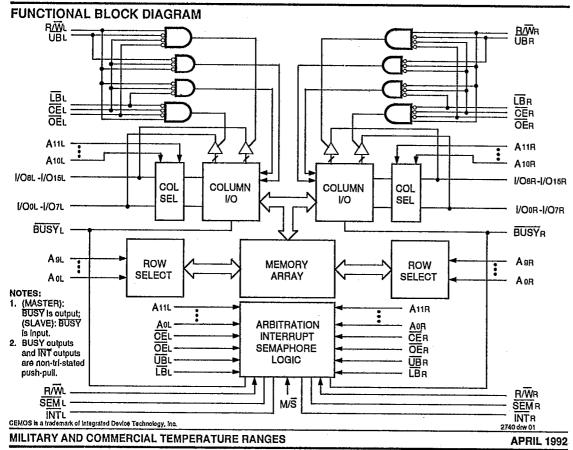
- True dual-ported memory cells which allow simultaneous reads of the same memory location
- High-speed access
 - Military: 35/45/55/70ns (max.)
 - Commercial: 25/30/35/45/55ns (max.)
- Low-power operation
 - IDT7024S
 - Active: 750mW (typ.)
 - Standby: 5mW (typ.)
- IDT7024L
 - Active: 750mW (typ.) Standby: 1mW (typ.)
- Separate upper-byte and lower-byte control for multiplexed bus compatibility
- IDT7024 easily expands data bus width to 32 bits or more using the Master/Slave select when cascading

more than one device

- M/S = H for BUSY output flag on Master M/S = L for BUSY input on Slave
- Interrupt Flag
- On-chip port arbitration logic
- Full on-chip hardware support of semaphore signaling between ports
- Fully asynchronous operation from either port
- Battery backup operation-2V data retention
- TTL compatible, single 5V (±10%) power supply
- Available in 84-pin PGA, quad flatpack and PLCC
- Industrial temperature range (-40°C to +85°C) is available, tested to military electrical specifications

DESCRIPTION:

The IDT7024 is a high-speed 4K \times 16 dual-port static RAM. The IDT7024 is designed to be used as a stand-alone 64K-bit



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IDT7024S/L HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

dual-port RAM or as a combination MASTER/SLAVE dualport RAM for 32-bit-or-more word systems. Using the IDT MASTER/SLAVE dual-port RAM approach in 32-bit or wider memory system applications results in full-speed, error-free operation without the need for additional discrete logic.

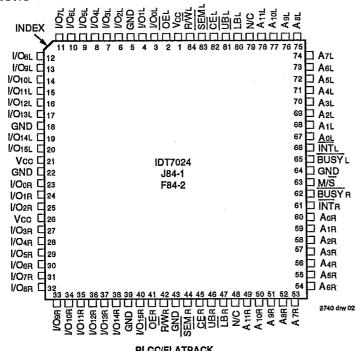
This device provides two independent ports with separate control, address, and I/O pins that permit independent, asynchronous access for reads or writes to any location in memory. An automatic power down feature controlled by CE

permits the on-chip circuitry of each port to enter a very low standby power mode.

Fabricated using IDT's CEMOS™ high-performance technology, these devices typically operate on only 750mW of power at maximum access times as fast as 25ns. Low-power (L) versions offer battery backup data retention capability with typical power consumption of 500µW from a 2V battery.

The IDT7024 is packaged in a ceramic 84-pin PGA, an 84-pin quad flatpack, and a PLCC. The military devices are processed 100% in compliance to the test methods of MIL-STD-883, Method 5004.

PIN CONFIGURATIONS





PLCC/FLATPACK TOP VIEW

- 1. All Vcc pins must be connected to power supply.
- 2. All GND pins must be connected to ground supply.

MILITARY AND COMMERCIAL TEMPERATURE RANGES

PIN CONFIGURATIONS (Continued)

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	63	61	60	58	55	1	1 -: -	· · · · · · ·				_
·	VO7L	VOSL	1/O4L		1	54	51	48	46	45	42	
	LUZE	I VOSE	1041	I/O2L	1/OoL	ŌĒL	SEML	LBL	A11L	A 10L	A7L	11
	66	64	65	59	56	49	50	47	44	43	40	-
	1/O10L	I/O ₈ L	I/O ₆ L	I/O3L	-VO1L	ÜBL	CEL	NC	Asr	AaL	Ası.	10
	67	65		. ·	57	53	52	 		41 .	39	1
	1/011L	I/O ₉ L			GND	Vcc	R∕WL			A6L	A4L	09
	69	68	1			_ _	<u> </u>	1		38	07	4
	I/O13L	I/O12L								AaL	37 A2L	08
	72	71	73			4-			<u> </u>			
	1/O15L	VO14L				٠.			33	35	34	
				-	÷	-	• • • •		BUSYL	Aol	ĪNTL	07
	75	70	74						32	31	36	1
	I/Oor	GND	GND			IDT7024 G84-3	4		GND	M/S	A1L	06
	76	77	78						28	29	30	
	l/O1R	I/O2R	Vcc						Aon	ĪNTR	BUSYR	05
	79	80							<u> </u>	26	27	
	I/O3R	I/O4R								A2R	A1R	04
	81	83	,		7	11	12			23	25	
	I/O5R	I/O7R			GND	GND	SEMR			A5R	Азп	03
	82	,1	2	5	8	10	14	17	20	22	24	
	I/O6R	VO9R	I/O10R	l/O13R	VO15R	R∕ŴR	ŪΒ̈́я	A11R	Aar	Aer	A4R	02
	84	3	4	6	9	15	13	16	18	19	21	
	I/Oar	1/011R	VO12R	I/O14R	OER	LBR	CER	N/C	A 10R	Aea	A7R	01
	Α	В	С		E	F	G	Н	J	K	L L	
Pin 4				•	84-D	IN PGA			-		2740	drw 03
Pin 1 Designator	,					VIEW	-					
PesiAttern)											

NOTES:
1. All Vcc pins must be connected to power supply.
2. All GND pins must be connected to ground supply.

PIN NAMES

Names
p Enable
ad/Write Enable
put Enable
dress
a Input/Output
naphore Enable
per Byte Select
ver Byte Select
rrupt Flag
y Flag
ster or Slave Select
ver
und

MILITARY AND COMMERCIAL TEMPERATURE RANGES

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TRUTH TABLE: NON-CONTENTION READ/WRITE CONTROL

		inpu	ıts ⁽¹⁾			Outp	outs	
CE	R/W	ŌĒ	BU	ĹB	SEM	I/O8-15	1/00-7	Mode
Н	X	X	X	Х	Н	Hi-Z	Hi-Z	Deselected: Power Down
Х	X	X	Н	Ι	Н	Hi-Z	Hi-Z	Both Bytes Deselected: Power Down
L,	11	х	L	Н	Н	DATAIN	Hi-Z	Write to Upper Byte Only
Ĺ	L	X	н	L.	Н	Hi-Z	DATAIN	Write to Lower Byte Only
L	L	Х	L	L	Н	DATAIN	DATAIN	Write to Both Bytes
L	Н	L,	L.	Н	Н	DATAOUT	Hi-Z	Read Upper Byte Only
L	Н	L	Н	L	Н	Hi•Z	DATAout	Read Lower Byte Only
Ļ	Н	L	L	L	Н	DATAOUT	DATAout	Read Both Bytes
X	X	Н	Х	X	X	Hi-Z	Hi-Z	Outputs Disabled
TE:			L	L				274

1. AOL --- A11L # AOR --- A11R

TRUTH TABLE: SEMAPHORE READ/WRITE CONTROL

	Outputs				uts	Inp		
 Mode	1/00-7	I/O8-15	SEM	LB	UB	ŌĒ	R/W	CE
Read Data in Semaphore Flag	DATAout	DATAOUT	L	Х	Х	L	Н	Н
 Read Data in Semaphore Flag	DATAout	DATAOUT	L	Н	Н	L.	Н	X
 Write Dเทง Into Semaphore Flag	DATAIN	DATAIN	L	Х	Х	Х	_J-	Н
 Write DING Into Semaphore Flag	DATAIN	DATAIN	L	Н	Н	X		Х
 Not Allowed	_	_	L	X	L	Х	X	L
 Not Allowed	-		L	L.	X	X	X	L

ABSOLUTE MAXIMUM RATINGS(1)

Symbol	Rating	Commercial	Military	Unit
VTERM ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +7.0	-0.5 to +7.0	٧
TA	Operating Temperature	0 to +70	-55 to +125	°C
TBIAS	Temperature Under Blas	-55 to +125	-65 to +135	°C
Тѕтв	Storage Temperature	-55 to +125	-65 to +150	°C
lout	DC Output Current	50	50	mΑ

RECOMMENDED OPERATING TEMPERATURE AND SUPPLY VOLTAGE

Grade	Amblent Temperature	GND	Vcc
Military	-55°C to +125°C	OV	5.0V ± 10%
Commercial	0°C to +70°C	0V	5.0V ± 10%

2740 tbl 05

2740 tbl 06



CONDITIONS

Symbol	Parameter	Min.	Тур.	Max.	Unit
Vcc	Supply Voltage	4.5	5.0	5.5	٧
GND	Supply Voltage	0	0	0	٧
ViH	Input High Voltage	2.2	_	6.0 ⁽²⁾	٧
VIL	Input Low Voltage	-0.5 ⁽¹⁾	_	0.8	٧

VIL≥ -3.0V for pulse width less than 20ns.
 VTERM must not exceed Vcc + 0.5V.

RECOMMENDED DC OPERATING

CAPACITANCE (TA = +25°C, f = 1.0MHz)

Symbol	Parameter ⁽¹⁾	Conditions	Max.	Unit
CIN	Input Capacitance	VIN = 0V	11	ρF
Cout	Output Capacitance	Vour = 0V	11	рF

NOTE:

2740 tb[03 1. This parameter is determined by device characterization but is not production tested.

NOTE: 2740 bil 04

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those Indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. VTERM must not exceed Vco + 0.5V.

MILITARY AND COMMERCIAL TEMPERATURE RANGES

DC ELECTRICAL CHARACTERISTICS OVER THE OPERATING TEMPERATURE AND SUPPLY VOLTAGE RANGE (Voc

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	TO TEME ENATORIC AN	D SUFFET VOLTAGE HAT	MGE (VCC	$= 5.0V \pm 1$	10%)	
			IDT7	0248	IDT70)2
Symbol	Parameter	Test Conditions	Min.	Max.	Min.	Γ
Heat	Innext and and Occurs (5)				 	╄

			IDT7	0248	IDT7		
Symbol	Parameter Parameter	Test Conditions	Min.	Max.	Min.	Max.	Unit
Lu	Input Leakage Current ⁽⁵⁾	Vcc = 5.5V, VIN = 0V to Vcc	_	10		5	μА
lro	Output Leakage Current	CE = VIH, VOUT = 0V to VCC		10		5	μА
Vol	Output Low Voltage	IOL = 4mA		0.4		0.4	V V
Vон	Output High Voltage	lон = -4mA	2.4		2.4	<u> </u>	l v

2740 tbl 07

DC ELECTRICAL CHARACTERISTICS OVER THE OPERATING TEMPERATURE AND SUPPLY VOLTAGE RANGE(1) (Vcc = 5.0V ± 10%)

		Test			COMI	4X25 L ONLY	COM'L	4X30 ONLY	7024	X35	
Symbol	Parameter	Condition	Version		Typ. ⁽²⁾	Max.	Typ. ⁽²⁾	Max.	Typ. ⁽²⁾	Max.	Uni
lcc	Dynamic Operating Current	CE ≤ VIL, Outputs Open SEM ≥ VIH	MIL.	S	_	_		=	160 160	400 340	mA
	(Both Ports Active)	f ≈ fMAX ⁽³⁾	COM'L.	S L	170 170	360 310	165 165	350 300	160 160	340 290	
IS81	Standby Current (Both Ports — TTL	CER = CEL≥ VIH SEMR = SEML≥ VIH	MIL.	S	_	/ <u></u>	=	<u> </u>	20 20	85 65	mΑ
	Level Inputs)	f = fMAX ⁽³⁾	COM'L.	S L	25 25	.70 .50	22 22	70 50	20 20	70 50	
ISB2	Standby Current	CEL or CER≥ VIH	MIL.	S	_				95	290	mΑ
	(One Port — TTL	Active Port Outputs Open		L	_ <i>.</i>	Single-			95	250	
	Level Inputs)	$f = fMAX^{(3)}$	COM'L.	s	105≪	250	100	250	95	240	1
		SEMR = SEML≥ VIH		L.	105	220	100	215	95	210	1
ISB3	Full Standby Current (Both Ports — All	Both Ports CEL and CER ≥ Vcc - 0,2V	MIL.	S		 	_	-	1.0 0.2	30 10	mΑ
	CMOS Level Inputs)	Vin ≥ Vcc - 0.2V or Vin ≤ 0.2V, $f = 0^{(4)}$ SEMR = SEML≥ Vcc - 0.2V	COM'L	S L	1,0 0.2	15 5	1.0 0.2	15 5	1.0 0.2	15 5	
ISB4	Full Standby Current (One Port — All CMOS Level Inputs)	One Port CEL or CER ≥ Vcc - 0,2V SEMR = SEML≥ Vcc - 0,2V	MIL.	S L		1 1	_	-	90 90	260 215	mA
		Vin ≥ Vcc - 0.2V or Vin ≤ 0.2V	COM'L.	S	100	230	95	230	90	220	
		Active Port Outputs Open, f = fMAX ⁽³⁾		L	100	190	95	190	90	180	

NOTES:

X in part numbers indicates power rating (S or L)
 Vcc = 5V, TA = +25°C.

4. f = 0 means no address or control lines change.
5. At Vcc ≤ 2.0V input leakages are undefined.

^{3.} At f = fMAX, address and control lines (except Output Enable) are cycling at the maximum frequency read cycle of 1/trc, and using "AC Test Conditions" of input levels of GND to 3V.

MILITARY AND COMMERCIAL TEMPERATURE RANGES

DC ELECTRICAL CHARACTERISTICS OVER THE OPERATING TEMPERATURE AND SUPPLY VOLTAGE RANGE⁽¹⁾(Continued) (Vcc = 5.0V ± 10%)

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		Test				1X45		1X55	7024 MIL C	NLY	
Symbol	Parameter	Condition	Versio	n	Тур. ⁽²⁾	Max.	Typ. ⁽²⁾	Max.	Typ. ⁽²⁾	Max.	Unit
lco	Dynamic Operating Current	CE ≤ VIL, Outputs Open SEM ≥ VIH	MIL.	S	155 155	400 340	150 150	395 335	140 140	390 330	mA
	(Both Ports Active)	f = fmax ⁽³⁾	COM'L.	S L	155 155	340 290	150 150	335 285	_		1
ISB1	Standby Current (Both Ports — TTL	CEL = CER≥ VIH SEMR = SEML≥ VIH	MIL.	S	16 16	85 65	13 13	85 65	10 10	85 65	mA
	Level Inputs)	f = fMAX ⁽³⁾	COM'L.	S L	16 16	70 50	13 13	70 50	-	-	
ISB2	Standby Current	CER or CEL≥ VIH	MIL.	S	90	290	85	290	80	290	mΑ
	(One Port TTL	Active Port Outputs Open		L,	90	250	85	250	80	250	
	Level Inputs)	$f = fMAX^{(3)}$	COM'L.	S	90	240	85	240			1
		SEMR = SEML≥ VIH		L	90	210	85	210	- -	1	<u> </u>
ISB3	Full Standby Current (Both Ports — All	Both Ports CEL and CER ≥ Vcc - 0.2V	MIL.	S L	1.0 0.2	30 10	1.0 0.2	30 10	1.0 0.2	30 10	mΑ
	CMOS Level Inputs)	Vin ≥ Vcc - 0.2V or Vin ≤ 0.2V, f = 0 ⁽⁴⁾ SEMR = SEML≥ Vcc - 0.2V	COM'L.	S	1.0 0.2	15 5	1.0 0.2	15 5	_	_	
ISB4	Full Standby Current (One Port — All	One Port CEL or CER ≥ Vcc - 0.2V	MIL.	s	85	260	80	260	75	260	mA
	CMOS Level Inputs)	SEMR = SEML≥ Vcc - 0.2V	1	L	85	215	80	215	75	215]
		Vin ≥ Vcc - 0.2V or Vin ≤ 0.2V	COM'L.	S	85	220	80	220	-	_	
		Active Port Outputs Open,		L	85	180	80	180	-	-	

NOTES:

X in part numbers indicates power rating (S or L)
 Vco = 5V, TA = +25°C.

3. At I = fMAX, address and control lines (except Output Enable) are cycling at the maximum frequency read cycle of 1/tro, and using "AC Test Conditions" of input levels of GND to 3V.

4. f = 0 means no address or control lines change.



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IDT7024S/L HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

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MILITARY AND COMMERCIAL TEMPERATURE RANGES

DATA RETENTION CHARACTERISTICS OVER ALL TEMPERATURE RANGES (L Version Only)

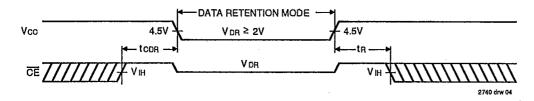
(VLC = 0.2V, VHC = VCC - 0.2V)

Symbol	Parameter	Test Condition		Min.	Тур. ⁽¹⁾	Max.	Unit
Vor	Vcc for Data Retention	Vcc = 2V		2.0	_	_	٧
ICCOR	Data Retention Current	CE ≥ VHC	MIL.		100	4000	μА
	·	Vin ≥ VHC or ≤ VLC	COM'L.		100	1500	1
todr ⁽³⁾	Chip Deselect to Data Retention Time			0	-		ns
tA ⁽³⁾	Operation Recovery Time			tRC ⁽²⁾			ns

NOTES:

- 1. TA = +25°C, Vcc = 2V
- 2. tRc = Read Cycle Time
- 3. This parameter is guaranteed but not tested.

DATA RETENTION WAVEFORM



AC TEST CONDITIONS

GND to 3.0V
5ns Max.
1.5V
1.5V
See Figures 1 & 2

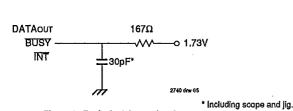


Figure 1. Equivalent Output Load

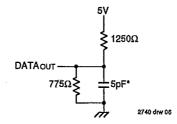


Figure 2. Output Load (for ILZ, tHZ, tWZ, tOW)

MILITARY AND COMMERCIAL TEMPERATURE RANGES

AC ELECTRICAL CHARACTERISTICS OVER THE OPERATING TEMPERATURE AND SUPPLY VOLTAGE RANGE⁽⁴⁾

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		1	24X25 ONLY		24X30 ONLY	10170	24X35	
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
READ CY	CLE							
tac	Read Cycle Time	25		30	_	35	-	ns
taa	Address Access Time		25	T -	30		35	ns
tace	Chip Enable Access Time ⁽³⁾	_	25	T —	30		35	ns
t ABE	Byte Enable Access Time ⁽³⁾	<u>`</u>	25	 	30	-	35	ns
tace	Output Enable Access Time	- ::	13	-	15		20	ns
ton	Output Hold from Address Change	3 ≪	<u>* – </u>	3	-	3		ns
tLZ	Output Low Z Time ^(1, 2)	3 🐃	<u>. – </u>	3		3		ns
tHZ	Output High Z Time ^(1, 2)	_2000 8 y	15	=	15		15	ns
tpu	Chip Enable to Power Up Time ⁽²⁾	0	-	O	_	0		ns
teo	Chip Disable to Power Down Time ⁽²⁾		50	 	50		50	ns
tsop	Semaphore Flag Update Pulse (OE or SEM)	12		15		.15		ns

		IDT70	24X45	IDT70	24X55	IDT70 MIL 0		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
READ CY	CLE							
trc	Read Cycle Time	45		55	_	70		ns
taa	Address Access Time		· 45	-	. 55	_	70	ns
tace	Chip Enable Access Time ⁽³⁾		45	_	55	-	. 70	ns
tabe	Byte Enable Access Time ⁽³⁾	_	45		55	_	70	ns
TACE	Output Enable Access Time		25	T —	30	_	35	ns
ton	Output Hold from Address Change	3		- 3	_	3	—	ns
tız	Output Low Z Time ^(1, 2)	5	_	5	-	5		ns
tHZ	Output High Z Time ^(1, 2)		20	_	25	-	30	ns
tPU	Chip Enable to Power Up Time(2)	0	<u> </u>	0	_	0	-	ns
tPD	Chip Disable to Power Down Time ⁽²⁾	_	50		50		50	ns
tsop	Semaphore Flag Update Pulse (OE or SEM)	15	—	15	_	15		ns



NOTES:

1. Transition is measured ±500mV from low or high impedance voltage with load (figures 1 and 2).

2. This parameter is guaranteed but not tested.

3. To access RAM, CE = L, UB or LB = L, SEM = H.

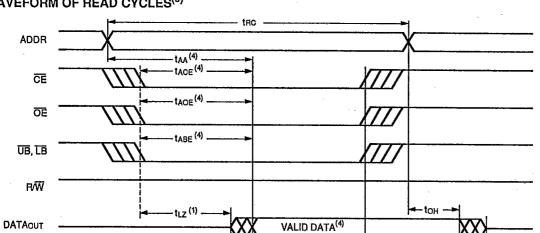
4. X in part numbers indicates power rating (S or L).

-t_{HZ} (2)

2740 drw Q7

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WAVEFORM OF READ CYCLES⁽⁵⁾



NOTES:

BUSYOUT

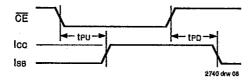
- Timing depends on which signal is asserted last, OE, CE, LB, or UB.
 Timing depends on which signal is de-asserted firs CE, OE, LB, or UB.
- topo delay is required only in cases where opposite port is completing a write operation to the same address location. For simultaneous read operations BUSY has no relation to valid output data.

 Start of valid data depends on which timing becomes effective last table, table

-t_{BDD} ^(3, 4)

- 5. SEM = H.

TIMING OF POWER-UP POWER-DOWN



HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

MILITARY AND COMMERCIAL TEMPERATURE RANGES

AC ELECTRICAL CHARACTERISTICS OVER THE OPERATING TEMPERATURE AND SUPPLY VOLTAGE (5)

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			24X25 L ONLY		24X30 ONLY	0לדמו	24X35	
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
WRITE C	YCLE							
two	Write Cycle Time	25	-	30		35	-	nş
tew	Chip Enable to End of Write ⁽³⁾	20) 	25		30	I —	ns
taw	Address Valid to End of Write	20	<u> </u>	25	-	30	I . —	ns
tas	Address Set-up Time ⁽³⁾	0	<u> </u>	0		0		ns
twp	Write Pulse Width	20		25	<u> </u>	30	-	ns
twn	Write Recovery Time	0	· · · · · · · · · · · · · · · · · · ·	0		0	T —	ns
tow	Data Valid to End of Write	15 🦔	<u>> -</u>	20	-	25	I –	ns
tHZ	Output High Z Time(1, 2)	-	15		15	_	15	ns
ton	Data Hold Time ⁽⁴⁾	0)	i —	0		0	T	ns
twz	Write Enable to Output in High Z ^(1, 2)	7%	15	T	15	_	15	ns
tow	Output Active from End of Write ^(1, 2, 4)	9	-	0	-	0	_	ns
tswad	SEM Flag Write to Read Time	10		10	T -	10		ns
tsps	SEM Flag Contention Window	10	T-	10		10		ns

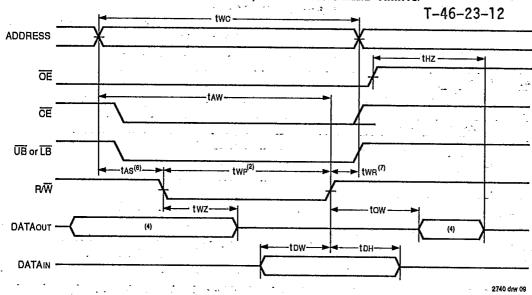
		IDT70	24X45	IDT70	24X55	IDT70 MIL.		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Uni
WRITE C	YCLE				,			
twc	Write Cycle Time	45		55		70	<u> </u>	ns
tew	Chip Enable to End of Write ⁽³⁾	40	-	45	_	50		ns
taw	Address Valid to End of Write	40		45		50		ns
tas	Address Set-up Time ⁽³⁾	0	_	0		0	 	ns
twp	Write Pulse Width	35	_	40	-	50		ns
twa	Write Recovery Time	0		0	l –	0		. ns
tow	Data Valid to End of Write	25	_	30	-	40	T	ns
tHZ	Output High Z Time ^(1, 2)		20	-	25	_	30	ns
ton	Data Hold Time ⁽⁴⁾	0		0	l —	0		ns
twz	Write Enable to Output in High Z ^(1, 2)		20		25	<u> </u>	30	ns
tow	Output Active from End of Write ^(1, 2, 4)	0	_	0	-	0		ns
tswrd	SEM Flag Write to Read Time	10	_	10	_	10	T —	n
tsps	SEM Flag Contention Window	10		10		10	T ==	ns
tsps NOTES:	SEM Flag Contention Window	10	<u> </u>	J 10	L.=	J 10	:ـــــــــــــــــــــــــــــــــــــ	-



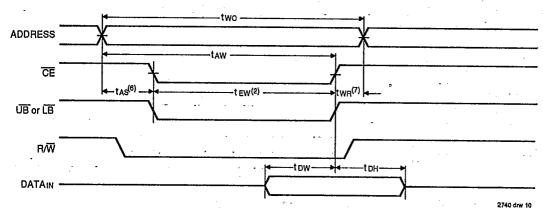
1. Transition is measured ±500mV from low or high impedance voltage with load (Figures 1 and 2).

This parameter is guaranteed but not tested.
 To access RAM, CE = L, UB or LB = L, SEM = H. To access semaphore, CE = H and SEM = L. Either condition must be valid for the entire tew time.
 The specification for ton must be met by the device supplying write data to the RAM under all operating conditions. Although ton and tow values will vary over voltage and temperature, the actual ton will always be smaller than the actual tow.
 X in part numbers indicates power rating (S or L).

TIMING WAVEFORM OF WRITE CYCLE NO. 1, R/W CONTROLLED TIMING (1,3,5,8)



TIMING WAVEFORM OF WRITE CYCLE NO. 2, CE, UB, LB CONTROLLED TIMING(1,3,5,8)



- NOTES:

 1. R/W must be high during all address transitions.

 2. A write occurs during the overlap (tew or twr) of a low U8 or LB and a low CE and a low R/W for memory array writing cycle.

 3. twn is measured from the earlier of CE or R/W (or SEM or R/W) going high to the end of write cycle.

 4. During this period, the I/O pins are in the output state and input signals must not be applied.

 5. If the CE or SEM low transition occurs simultaneously with or after the R/W low transition, the outputs remain in the high impedance state.

 6. Timing depends on which enable signal is asserted last, CE, R/W or byte control.

 7. Timing depends on which enable signal is de-asserted first, CE, R/W or byte control.

 8. If OE is low during R/W controlled write cycle, the write pulse width must be the larger of two or (twz + tow) to allow the I/O drivers to turn off and data to be placed on the bus for the required tow. If OE is high during an R/W controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified twe. as short as the specified twp.

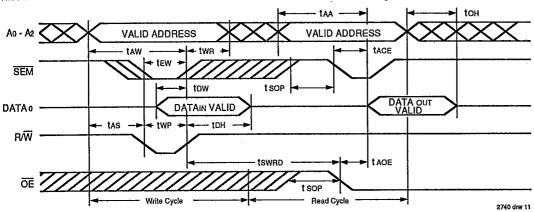
47E D ■ 4825771 0009874 2 ■ IDT

HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

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MILITARY AND COMMERCIAL TEMPERATURE RANGES

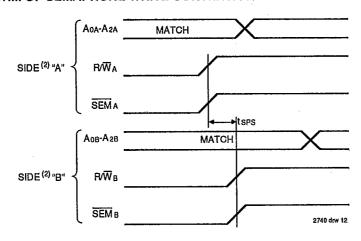
TIMING WAVEFORM OF SEMAPHORE READ AFTER WRITE TIMING, EITHER SIDE(1)



NOTE:

1. CE = H for the duration of the above timing (both write and read cycle).

TIMING WAVEFORM OF SEMAPHORE WRITE CONTENTION(1,3,4)





- 1. Don = Dol = L, ĈĒn = ĈĒl = H, Semaphore Flag is released from both sides (reads as ones from both sides) at cycle start.

 2. "A" may be either left or right port. "B" is the opposite port from "A".

 3. This parameter is measured from R/WA or SEMA going high to R/Ws or SEMs going high.

 4. If tsps is violated, the semaphore will fall positively to one side or the other, but there is not guarantee which side will obtain the flag.

MILITARY AND COMMERCIAL TEMPERATURE RANGES

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AC ELECTRICAL CHARACTERISTICS OVER THE OPERATING TEMPERATURE AND SUPPLY VOLTAGE RANGE⁽⁶⁾

			24X25 ONLY		24X30 L ONLY	IDT70)24X35	
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
BUSY TIM	1ING (M/S = H)							
t BAA	BUSY Access Time from Address Match		25	_	30	<u> </u>	35	ns
TBDA	BUSY Disable Time from Address Not Matched		20	_	25	_	30	ns
TBAC	BUSY Access Time from Chip Low		.20	_	25		30	ns
taoc	BUSY Disable Time from Chip High	_ *	17	-	20		25	ns
taps	Arbitration Priority Set-up Time ⁽²⁾	5 .	—	5		5		ns
(BDD	BUSY Disable to Valid Data ⁽³⁾	%	Note 3		Note 3	_	Note 3	ns
BUSYTIM	IING (M/S = L)	(100) 40.00	300 1002	·	<u> </u>	•	<u></u>	
twB	BUSY Input to Write ⁽⁴⁾	0	- I	0		0	T	ns
twn	Write Hold After BUSY ⁽⁵⁾	17.	_	20		25		ns
PORT-TO	-PORT DELAY TIMING	Z.	······		L		L	
twop	Write Pulse to Data Delay ⁽¹⁾	4.	50	_	55	_	60	ns
tooo	Write Data Valid to Read Data Delay ⁽¹⁾	_	35	_	40		45	ns

		IDT70	IDT7024X45		24X55	IDT7024X70 MIL, ONLY			
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit	
BUSY TIM	IING (M/S = H)						-		
tBAA	BUSY Access Time from Address Match		35		45	_	45	ns	
tBDA	BUSY Disable Time from Address Not Matched		30	_	40		40	ns	
tBAC	BUSY Access Time from Chip Enable Low		30	_	40	_	40	ns	
tedo	BUSY Disable Time from Chip Enable High	_	25		35	_	35	ns	
taps .	Arbitration Priority Set-up Time ⁽²⁾	5	_	5	 	5		ns	
t800	BUSY Disable to Valid Data ⁽³⁾		Note 3		Note 3		Note 3	ns	
BUSY TIM	IING (M/S = L)				<u> </u>			1-11-	
twe	BUSY Input to Write ⁽⁴⁾	0		0	_	0	Γ =	ns	
twn	Write Hold After BUSY ⁽⁵⁾	25	_	25		25		ns	
PORT-TO	-PORT DELAY TIMING	—— I	·	<u> </u>	l		L		
twoo	Write Pulse to Data Delay ⁽¹⁾	T	70		80	_	95	ns	
tooo	Write Data Valid to Read Data Delay(1)		55		65		80	ns	

NOTES:

1. Port-to-port delay through RAM cells from writing port to reading port, refer to "Timing Waveform of Read With BUSY (WS = H)" or "Timing Waveform of Write With Port-To-Port Delay (WS=L)".

2. To ensure that the earlier of the two ports wins.

3. tBDD is a calculated parameter and is the greater of 0, tWDD – tWP (actual) or tDDD – tDW (actual).

4. To ensure that the write cycle is inhibited during contention.

5. To ensure that a write cycle is completed after contention.

6. "x" is part numbers indicates power rating (S or L). 2740 tbl 13



47E D 4825771 0009876 6 mm IDT

t woo

t DDD (3)

IDT7024S/L HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

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T-46-23-12 TIMING WAVEFORM OF READ WITH $\overline{BUSY}^{(2)}$ (M/S = H) MATCH ADDRR R∕WR tow. ► toH VALID DATAINR taps (1) MATCH ADDR L teop - t BDA

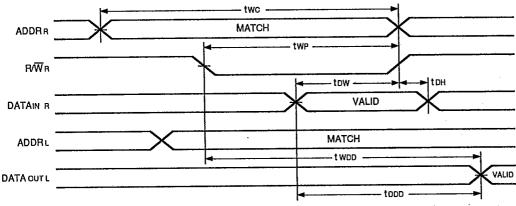
NOTES:

- To ensure that the earlier of the two ports wins.
 CEL = CER = L
- 3. OE = L for the reading port.

BUSYL

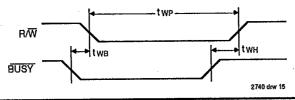
DATAOUTL

TIMING WAVEFORM OF WRITE WITH PORT-TO-PORT DELAY^(1,2) (M/ \overline{S} = L)



- NOTES:
 1. BUSY input equals H for the writing port.
 2. OEL = CER = L

TIMING WAVEFORM OF SLAVE WRITE (M/ $\overline{S} = L$)



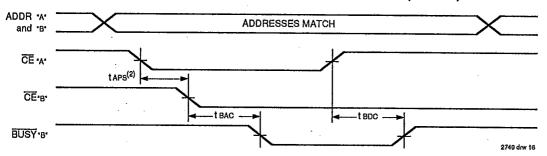
VALID

2740 drw 13

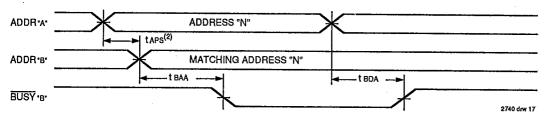
HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

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WAVEFORM OF BUSY ARBITRATION CONTROLLED BY CE TIMING(1) (M/S = H)



WAVEFORM OF BUSY ARBITRATION CYCLE CONTROLLED BY ADDRESS MATCH $TIMING^{(1)}(M/\overline{S} = H)$



NOTES:

- All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from "A".
 If two is violated, the busy signal will be asserted on one side or another but there is no guarantee on which side busy will be asserted.

AC ELECTRICAL CHARACTERISTICS OVER THE OPERATING TEMPERATURE AND SUPPLY VOLTAGE RANGE⁽¹⁾

		IDT7024) COM'L OI		024X30 L ONLY	IDT70	Unit	
Symbol	Parameter	Min. N	lax. Min.	Min. Max.			Max.
INTERRU	IPT TIMING				<u></u>		
tas	Address Set-up Time	0	0	T —	0	<u> </u>	ns
twa	Write Recovery Time	0	_ 0	_	0	-	ns
tins	Interrupt Set Time		20	25		30	ns
tina	Interrupt Reset Time		20 —	25	_	30	ns

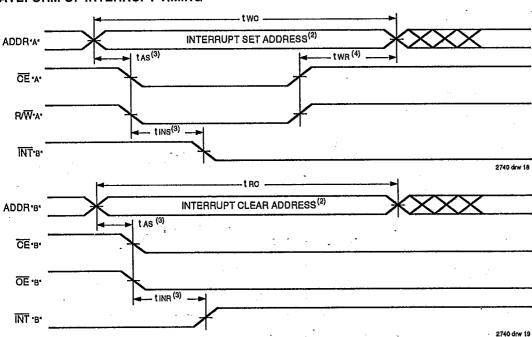
		IDT70	IDT7024X45		24X55	IDT70 MIL.		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
INTERRU	PT TIMING							
tas	Address Set-up Time	. 0		0		0		ns
twn	Write Recovery Time	0		0		0		ns
tins	Interrupt Set Time	_	35	1 -	40		50	ns
tinn	Interrupt Reset Time		35	 	40		50	ns

NOTE: 1. "x" in part numbers indicates power rating (S or L).

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WAVEFORM OF INTERRUPT TIMING(1)

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NOTES:

- All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from "A".
 See Interrupt truth table.
 Timing depends on which enable signal is asserted last.
 Timing depends on which enable signal is de-asserted first.



TRUTH TABLES

TRUTH TABLE I — INTERRUPT FLAG(1)

	Le	ft Port			Right Port			Right Port		
R/WL	CEL	OE L	AOL-A11L	INTL	R/WR	CER	OER	AOR-A11R	INTR	Function
_[L	Х	FFF	Χ	X	X	X	Х	L(2)	Set Right INTR Flag
X	X	Х	Х	X.	Х	L	L.	FFF	H ⁽³⁾	Reset Right INTR Flag
X	X	Х	X	L(3)	L	L	X	FFE	X	Set Left INTL Flag
X	L		FFE	H ⁽²⁾	X	X	X	X	Х	Reset Left INTL Flag

NOTES:

- Assumes BUSYL = BUSYR = H.
 If BUSYL = L, then no change.
 If BUSYR = L, then no change.

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TRUTH TABLE II - ADDRESS BUSY **ARBITRATION**

	lnp	Inputs Outputs			
CEL	CER	A0L-A11L A0R-A11R			Function
X	X	NO MATCH	Н	H	Normal
Н	X	MATCH	Н	Н	Normal
Х	Н	MATCH	Н	Н	Normal
L	L	MATCH	(2)	(2)	Write Inhibit ⁽³⁾

2740 thi 16

- 1. Pins BUSYL and BUSYR are both outputs when the part is configured as a master. Both are inputs when configured as a slave. BUSYx outputs on the IDT7024 are push pull, not open drain outputs. On slaves the BUSYx input internally inhibits writes
- Lif the inputs to the opposite port were stable prior to the address and enable inputs of this port. Hif the inputs to the opposite port became stable after the address and enable inputs of this port. If two is not met, either BUSYL or BUSYR = Low will result. BUSYL and BUSYR outputs cannot be low simultaneouty. Writes to the left port are internally ignored when BUSYL outputs are driving low regardless of actual logic level on the pin. Writes to the right port are
- internally ignored when BUSYn outputs are driving low regardless of actual logic level on the pin.

TRUTH TABLE III — EXAMPLE OF SEMAPHORE PROCUREMENT SEQUENCE(1)

Functions	Do - D15 Left	Do - D15 Right	Status
No Action	1	1	Semaphore free
Left Port Writes "0" to Semaphore	0	1	Left port has semaphore token
Right Port Writes "0" to Semaphore	0	1	No change. Right side has no write access to semaphore
Left Port Writes "1" to Semaphore	1	0	Right port obtains semaphore token
Left Port Writes "0" to Semaphore	1	0	No change. Left port has no write access to semaphore
Right Port Writes "1" to Semaphore	0	1	Left port obtains semaphore token
Left Port Writes "1" to Semaphore	1	1	Semaphore free
Right Port Writes "0" to Semaphore	1	0	Right port has semaphore token
Right Port Writes "1" to Semaphore	1	1	Semaphore free
Left Port Writes "0" to Semaphore	0	1	Right port has semaphore token
Left Port Writes "1" to Semaphore	1	1	Semaphore free

NOTE:

1. This table denotes a sequence of events for only one of the eight semaphores on the IDT7024.

2740 tbl 17

FUNCTIONAL DESCRIPTION

The IDT7024 provides two ports with separate control, address and I/O pins that permit independent access for reads or writes to any location in memory. The IDT7024 has an automatic power down feature controlled by CE. The CE controls on-chip power down circuitry that permits the respective port to go into a standby mode when not selected (CE high). When a port is enabled, access to the entire memory array is permitted.

INTERRUPTS

If the user chooses to use the interrupt function, a memory location (mail box or message center) is assigned to each port. The left port interrupt flag (INTL) is set when the right port writes to memory location FFE (HEX). The left port clears the interrupt by reading address location FFE. Likewise, the right port interrupt flag (INTR) is set when the left port writes to memory location FFF (HEX) and to clear the interrupt flag (INTR), the right port must read the memory location FFF. The message (16 bits) at FFE or FFF is user-defined. If the interrupt function is not used, address locations FFE and FFF are not used as mail boxes, but as part of the random access memory. Refer to Table I for the interrupt operation.

BUSY LOGIC

Busy Logic provides a hardware indication that both ports of the RAM have accessed the same location at the same time. It also allows one of the two accesses to proceed and signals the other side that the RAM is "busy". The busy pin can then be used to stall the access until the operation on the other side is completed. If a write operation has been attempted from the side that receives a busy indication, the write signal is gated internally to prevent the write from proceeding.

The use of busy logic is not required or desirable for all applications. In some cases it may be useful to logically OR the busy outputs together and use any busy indication as an interrupt source to flag the event of an illegal or illogical

HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

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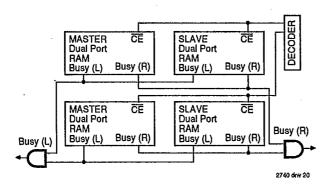


Figure 3. Busy and chip enable routing for both width and depth expansion with IDT7024 RAMs.

operation. If the write inhibit function of busy logic is not desirable, the busy logic can be disabled by placing the part in slave mode with the M/S pin. Once in slave mode the BUSY pin operates solely as a write inhibit input pin. Normal operation can be programmed by tying the BUSY pins high. If desired, unintended write operations can be prevented to a port by tying the busy pin for that port low.

The busy outputs on the IDT 7024 RAM in master mode, are push-pull type outputs and do not require pull up resistors to operate. If these RAMs are being expanded in depth, then the busy indication for the resulting array requires the use of an external AND gate.

WIDTH EXPANSION WITH BUSY LOGIC MASTER/SLAVE ARRAYS

When expanding an IDT7024 RAM array in width while using busy logic, one master part is used to decide which side of the RAM array will receive a busy indication, and to output that indication. Any number of slaves to be addressed in the same address range as the master, use the busy signal as a write inhibit signal. Thus on the IDT7024 RAM the busy pin is an output if the part is used as a master (M/\overline{S} pin = H), and the busy pin is an input if the part used as a slave (M/\overline{S} pin = L) as shown in Figure 3.

If two or more master parts were used when expanding in width, a split decision could result with one master indicating busy on one side of the array and another master indicating busy on one other side of the array. This would inhibit the write operations from one port for part of a word and inhibit the write operations from the other port for the other part of the word.

The busy arbitration, on a master, is based on the chip enable and address signals only. It ignores whether an access is a read or write. In a master/slave array, both address and chip enable must be valid long enough for a busy flag to be output from the master before the actual write pulse can be initiated with either the R/W signal or the byte enables. Failure to observe this timing can result in a glitched internal write inhibit signal and corrupted data in the slave.

SEMAPHORES

The IDT7024 is an extremely fast dual-port 4K x 16 CMOS static RAM with an additional 8 address locations dedicated to binary semaphore flags. These flags allow either processor on the left or right side of the dual-port RAM to claim a privilege over the other processor for functions defined by the system designer's software. As an example, the semaphore can be used by one processor to inhibit the other from accessing a portion of the dual-port RAM or any other shared resource.

The dual-port RAM features a fast access time, and both ports are completely independent of each other. This means that the activity on the left port in no way slows the access time of the right port. Both ports are identical in function to standard CMOS static RAM and can be read from, or written to, at the same time with the only possible conflict arising from the simultaneous writing of, or a simultaneous READ/WRITE of, a non-semaphore location. Semaphores are protected against such ambiguous situations and may be used by the system program to avoid any conflicts in the non-semaphore portion of the dual-port RAM. These devices have an automatic power-down feature controlled by CE, the dual-port RAM enable, and SEM, the semaphore enable. The CE and SEM pins control on-chip power down circuitry that permits the respective port to go into standby mode when not selected. This is the condition which is shown in Truth Table where CE and SEM are both high.

Systems which can best use the IDT7024 contain multiple processors or controllers and are typically very high-speed systems which are software controlled or software intensive. These systems can benefit from a performance increase offered by the IDT7024's hardware semaphores, which provide a lockout mechanism without requiring complex programming.

Software handshaking between processors offers the maximum in system flexibility by permitting shared resources to be allocated in varying configurations. The IDT7024 does not use its semaphore flags to control any resources through hardware, thus allowing the system designer total flexibility in system architecture.



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IDT7024S/L HIGH-SPEED 4K x 16 DUAL-PORT STATIC RAM

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An advantage of using semaphores rather than the more common methods of hardware arbitration is that wait states are never incurred in either processor. This can prove to be a major advantage in very high-speed systems.

HOW THE SEMAPHORE FLAGS WORK

The semaphore logic is a set of eight latches which are independent of the dual-port RAM. These latches can be used to pass a flag, or token, from one port to the other to indicate that a shared resource is in use. The semaphores provide a hardware assist for a use assignment method called "Token Passing Allocation." In this method, the state of a semaphore latch is used as a token indicating that shared resource is in use. If the left processor wants to use this resource, it requests the token by setting the latch. This processor then verifies its success in setting the latch by reading it. If it was successful, it proceeds to assume control over the shared resource. If it was not successful in setting the latch, it determines that the right side processor has set the latch first, has the token and is using the shared resource. The left processor can then either repeatedly request that semaphore's status or remove its request for that semaphore to perform another task and occasionally attempt again to gain control of the token via the set and test sequence. Once the right side has relinquished the token, the left side should succeed in gaining control.

The semaphore flags are active low. A token is requested by writing a zero into a semaphore latch and is released when the same side writes a one to that latch.

The eight semaphore flags reside within the IDT7024 in a separate memory space from the dual-port RAM. This address space is accessed by placing a low input on the SEM pin (which acts as a chip select for the semaphore flags) and using the other control pins (Address, OE, and R/W) as they would be used in accessing a standard static RAM. Each of the flags has a unique address which can be accessed by either side through address pins A0-A2. When accessing the semaphores, none of the other address pins has any effect.

When writing to a semaphore, only data pin Do is used. If a low level is written into an unused semaphore location, that flag will be set to a zero on that side and a one on the other side (see Table III). That semaphore can now only be modified by the side showing the zero. When a one is written into the same location from the same side, the flag will be set to a one for both sides (unless a semaphore request from the other side is pending) and then can be written to by both sides. The fact that the side which is able to write a zero into a semaphore subsequently locks out writes from the other side is what makes semaphore flags useful in interprocessor communications. (A thorough discussing on the use of this feature follows shortly.) A zero written into the same location from the other side will be stored in the semaphore request latch for that side until the semaphore is freed by the first side.

When a semaphore flag is read, its value is spread into all data bits so that a flag that is a one reads as a one in all data bits and a flag containing a zero reads as all zeros. The read value is latched into one side's output register when that side's semaphore select (SEM) and output enable (OE) signals go

active. This serves to disallow the semaphore from changing state in the middle of a read cycle due to a write cycle from the other side. Because of this latch, a repeated read of a semaphore in a test loop must cause either signal (SEM or OE) to go inactive or the output will never change.

A sequence WRITE/READ must be used by the semaphore in order to guarantee that no system level contention will occur. A processor requests access to shared resources by attempting to write a zero into a semaphore location. If the semaphore is already in use, the semaphore request latch will contain a zero, yet the semaphore flag will appear as one, a fact which the processor will verify by the subsequent read (see Table III). As an example, assume a processor writes a zero to the left port at a free semaphore location. On a subsequent read, the processor will verify that it has written successfully to that location and will assume control over the resource in question. Meanwhile, if a processor on the right side attempts to write a zero to the same semaphore flag it will fail, as will be verified by the fact that a one will be read from that semaphore on the right side during subsequent read. Had a sequence of READ/WRITE been used instead, system contention problems could have occurred during the gap between the read and write cycles.

It is important to note that a failed semaphore request must be followed by either repeated reads or by writing a one into the same location. The reason for this is easily understood by looking at the simple logic diagram of the semaphore flag in Figure 4. Two semaphore request latches feed into a semaphore flag. Whichever latch is first to present a zero to the semaphore flag will force its side of the semaphore flag low and the other side high. This condition will continue until a one is written to the same semaphore request latch. Should the other side's semaphore request latch have been written to a zero in the meantime, the semaphore flag will flip over to the other side as soon as a one is written into the first side's request latch. The second side's flag will now stay low until its semaphore request latch is written to a one. From this it is easy to understand that, if a semaphore is requested and the processor which requested it no longer needs the resource, the entire system can hang up until a one is written into that semaphore request latch.

The critical case of semaphore timing is when both sides request a single token by attempting to write a zero into it at the same time. The semaphore logic is specially designed to resolve this problem. If simultaneous requests are made, the logic guarantees that only one side receives the token. If one side is earlier than the other in making the request, the first side to make the request will receive the token. If both requests arrive at the same time, the assignment will be arbitrarily made to one port or the other.

One caution that should be noted when using semaphores is that semaphores alone do not guarantee that access to a resource is secure. As with any powerful programming technique, if semaphores are misused or misinterpreted, a software error can easily happen.

Initialization of the semaphores is not automatic and must be handled via the initialization program at power-up. Since any semaphore request flag which contains a zero must be T-46-23-12

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reset to a one, all semaphores on both sides should have a one written into them at initialization from both sides to assure that they will be free when needed.

USING SEMAPHORES—SOME EXAMPLES

Perhaps the simplest application of semaphores is their application as resource markers for the IDT7024's dual-port RAM. Say the 4K x 16 RAM was to be divided into two 2K x 16 blocks which were to be dedicated at any one time to servicing either the left or right port. Semaphore 0 could be used to indicate the side which would control the lower section of memory, and Semaphore 1 could be defined as the indicator for the upper section of memory.

To take a resource, in this example the lower 2K of dual-port RAM, the processor on the left port could write and then read a zero in to Semaphore 0. If this task were successfully completed (a zero was read back rather than a one), the left processor would assume control of the lower 2K. Meanwhile the right processor was attempting to gain control of the resource after the left processor, it would read back a one in response to the zero it had attempted to write into Semaphore 0. At this point, the software could choose to try and gain control of the second 2K section by writing, then reading a zero into Semaphore 1. If it succeeded in gaining control, it would lock out the left side.

Once the left side was finished with its task, it would write a one to Semaphore 0 and may then try to gain access to Semaphore 1. If Semaphore 1 was still occupied by the right side, the left side could undo its semaphore request and perform other tasks until it was able to write, then read a zero into Semaphore 1. If the right processor performs a similar task with Semaphore 0, this protocol would allow the two processors to swap 2K blocks of dual-port RAM with each other.

The blocks do not have to be any particular size and can even be variable, depending upon the complexity of the software using the semaphore flags. All eight semaphores could be used to divide the dual-port RAM or other shared resources into eight parts. Semaphores can even be assigned different meanings on different sides rather than being given a common meaning as was shown in the example above.

Semaphores are a useful form of arbitration in systems like disk interfaces where the CPU must be locked out of a section of memory during a transfer and the I/O device cannot tolerate any wait states. With the use of semaphores, once the two devices has determined which memory area was "off-limits" to the CPU, both the CPU and the I/O devices could access their assigned portions of memory continuously without any wait

Semaphores are also useful in applications where no memory "WAIT" state is available on one or both sides. Once a semaphore handshake has been performed, both processors can access their assigned RAM segments at full speed.

Another application is in the area of complex data structures. In this case, block arbitration is very important. For this application one processor may be responsible for building and updating a data structure. The other processor then reads and interprets that data structure. If the interpreting processor reads an incomplete data structure, a major error condition may exist. Therefore, some sort of arbitration must be used between the two different processors. The building processor arbitrates for the block, locks it and then is able to go in and update the data structure. When the update is completed, the data structure block is released. This allows the interpreting processor to come back and read the complete data structure, thereby guaranteeing a consistent data structure.



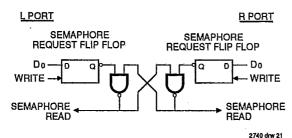


Figure 4. IDT7024 Semaphore Logic